

# S-5731 Series

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# HIGH-WITHSTAND VOLTAGE HIGH-SPEED UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC

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This IC, developed by CMOS technology, is a unipolar detection type Hall effect switch IC with high-withstand voltage, high-speed detection and high-accuracy magnetic characteristics.

The output voltage changes when this IC detects the intensity level of magnetic flux density. Using this IC with a magnet makes it possible to detect the open / close and rotation status in various devices.

This IC includes an output current limit circuit.

High-density mounting is possible by using the small SOT-23-3 package.

Due to its high-accuracy magnetic characteristics, this IC can make operation's dispersion in the system combined with magnet smaller.

ABLIC Inc. offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales office.

## ■ Features

• Pole detection\*1: Detection of S pole, detection of N pole

Output logic\*1: Active "L", active "H"
 Output form\*1: Nch open-drain output,

Nch driver + built-in pull-up resistor

• Magnetic sensitivity\*1:  $B_{OP} = 3.0 \text{ mT typ.},$ 

 $B_{OP} = 6.0 \text{ mT typ.}$   $f_{C} = 250 \text{ kHz typ.}$  $t_{D} = 16.0 \text{ } \mu\text{s typ.}$ 

• Power supply voltage range:

• Built-in regulator

• Chopping frequency:

Output delay time:

• Built-in output current limit circuit

• Operation temperature range:

• Lead-free (Sn 100%), halogen-free

\*1. The option can be selected.

Ta =  $-40^{\circ}$ C to  $+85^{\circ}$ C

 $V_{DD} = 3.5 \text{ V to } 26.0 \text{ V}$ 

# Applications

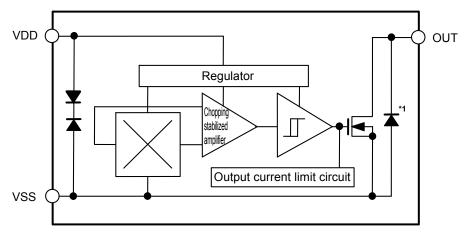
- Home appliance
- DC brushless motor
- Housing equipment
- Industrial equipment

## ■ Package

• SOT-23-3

# **■** Block Diagrams

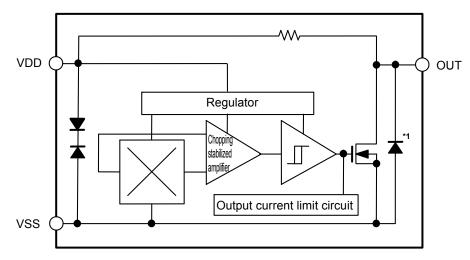
# 1. Nch open-drain output product



\*1. Parasitic diode

Figure 1

# 2. Nch driver + built-in pull-up resistor product



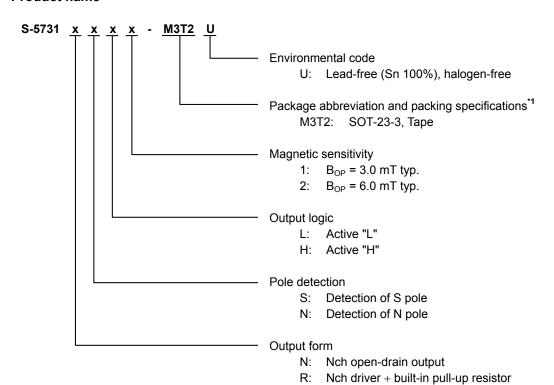
\*1. Parasitic diode

Figure 2

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## **■ Product Name Structure**

## 1. Product name



<sup>\*1.</sup> Refer to the tape drawing.

# 2. Package

Table 1 Package Drawing Codes

Package Name	Dimension	Tape	Reel	
SOT-23-3	MP003-C-P-SD	MP003-C-C-SD	MP003-Z-R-SD	

## 3. Product name list

Table 2

Product Name	Output Form	Pole Detection	Output Logic	Magnetic Sensitivity (B <sub>OP</sub> )
S-5731NSL1-M3T2U	Nch open-drain output	S pole	Active "L"	3.0 mT typ.
S-5731NSL2-M3T2U	Nch open-drain output	S pole	Active "L"	6.0 mT typ.
S-5731NNL2-M3T2U	Nch open-drain output	N pole	Active "L"	6.0 mT typ.
S-5731RSL1-M3T2U	Nch driver + built-in pull-up resistor	S pole	Active "L"	3.0 mT typ.

**Remark** Please contact our sales office for products other than the above.

# ■ Pin Configuration

## 1. SOT-23-3

Top view



Pin No. Symbol Description

1 VSS GND pin

2 VDD Power supply pin

Table 3

Output pin

Figure 3

# ■ Absolute Maximum Ratings

Table 4

OUT

3

(Ta = +25°C unless otherwise specified)

	Item	Symbol	Absolute Maximum Rating	Unit
Power supply voltage		$V_{DD}$	$V_{SS}-0.3$ to $V_{SS}+28.0$	V
Output current		I <sub>OUT</sub>	20	mA
Output valtage	Nch open-drain output product	.,	$V_{SS} - 0.3$ to $V_{SS} + 28.0$	V
Output voltage	Nch driver + built-in pull-up resistor product	V <sub>OUT</sub>	$V_{SS}-0.3$ to $V_{DD}+0.3$	V
Operation ambient temperature		T <sub>opr</sub>	−40 to +85	°C
Storage temperature		T <sub>stg</sub>	-40 to +125	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

# ■ Thermal Resistance Value

Table 5

Item	Symbol	Symbol Condition		Min.	Тур.	Max.	Unit
			Board A	-	200	_	°C/W
	$\theta_{JA}$		Board B	_	165	1	°C/W
Junction-to-ambient thermal resistance*1		SOT-23-3	Board C	_	_	1	°C/W
			Board D	_	ı	I	°C/W
			Board E	_	_	_	°C/W

<sup>\*1.</sup> Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

# **■** Electrical Characteristics

Table 6

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Power supply voltage	$V_{DD}$	-	3.5	12.0	26.0	V	_
Current consumption		Nch open-drain output product Average value	-	3.0	4.0	mA	1
Current consumption	I <sub>DD</sub>	Nch driver + built-in pull-up resistor product Average value, V <sub>OUT</sub> = "H"	ı	3.0	4.0	mA	1
Output valtage	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Nch open-drain output product Output transistor Nch, $V_{OUT}$ = "L", $I_{OUT}$ = 10 mA	-	_	0.4	V	2
Output voltage	V <sub>OUT</sub>	Nch driver + built-in pull-up resistor product Output transistor Nch, $V_{OUT}$ = "L", $I_{OUT}$ = 10 mA	-	-	0.5	V	2
Output drop voltage	V <sub>D</sub>	Nch driver + built-in pull-up resistor product $V_{OUT}$ = "H", $V_D$ = $V_{DD} - V_{OUT}$	ı	_	20	mV	2
Leakage current	I <sub>LEAK</sub>	Nch open-drain output product Output transistor Nch, V <sub>OUT</sub> = "H" = 26.0 V	-	_	10	μА	3
Output limit current	I <sub>OM</sub>	V <sub>OUT</sub> = 12.0 V	22	_	70	mA	3
Output delay time	t <sub>D</sub>	ı	-	16.0	_	μS	_
Chopping frequency	$f_C$	ľ	-	250	_	kHz	_
Start up time	t <sub>PON</sub>	-	-	30	_	μS	4
Outrout vice time		Nch open-drain output product $C = 20 \text{ pF}, R = 820 \Omega$	-	_	2.0	μS	5
Output rise time t <sub>R</sub>		Nch driver + built-in pull-up resistor product C = 20 pF		_	6.0	μS	5
Output fall time	t <sub>F</sub>	C = 20 pF, R = 820 Ω	-	_	2.0	μS	5
Pull-up resistor	$R_L$	Nch driver + built-in pull-up resistor product	7	10	13	kΩ	_

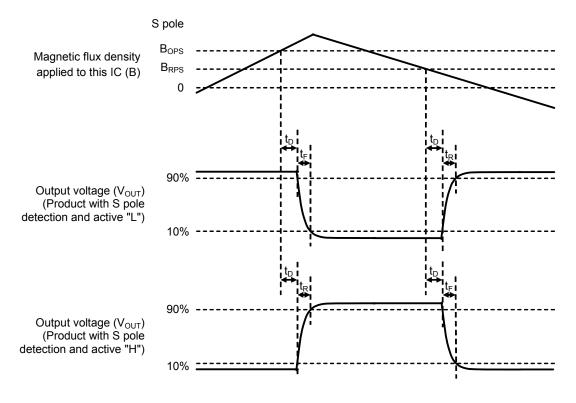


Figure 4 Operation Timing

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# ■ Magnetic Characteristics

#### 1. Product with S pole detection

1. 1 Product with  $B_{OP} = 3.0 \text{ mT typ.}$ 

#### Table 7

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B <sub>OPS</sub>	_	1.5	3.0	4.5	mT	4
Release point*2	S pole	B <sub>RPS</sub>	_	1.0	2.0	3.3	mT	4
Hysteresis width*3	S pole	B <sub>HYSS</sub>	$B_{HYSS} = B_{OPS} - B_{RPS}$	-	1.0	-	mT	4

#### 1. 2 Product with $B_{OP} = 6.0 \text{ mT typ.}$

#### Table 8

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B <sub>OPS</sub>	_	3.0	6.0	9.0	mT	4
Release point*2	S pole	B <sub>RPS</sub>	_	2.5	4.5	7.5	mT	4
Hysteresis width*3	S pole	B <sub>HYSS</sub>	$B_{HYSS} = B_{OPS} - B_{RPS}$	_	1.5	ì	mT	4

## 2. Product with N pole detection

#### 2. 1 Product with $B_{OP} = 6.0$ mT typ.

Table 9

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	N pole	B <sub>OPN</sub>	_	-9.0	-6.0	-3.0	mT	4
Release point*2	N pole	B <sub>RPN</sub>	_	-7.5	-4.5	-2.5	mT	4
Hysteresis width*3	N pole	B <sub>HYSN</sub>	$B_{HYSN} =  B_{OPN} - B_{RPN} $	ı	1.5	I	mT	4

<sup>\*1.</sup> B<sub>OPN</sub>, B<sub>OPS</sub>: Operation points

 $B_{OPN}$  and  $B_{OPS}$  are the values of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is increased (by moving the magnet closer).

Even when the magnetic flux density exceeds B<sub>OPN</sub> or B<sub>OPS</sub>, V<sub>OUT</sub> retains the status.

## **\*2.** B<sub>RPN</sub>, B<sub>RPS</sub>: Release points

 $B_{RPN}$  and  $B_{RPS}$  are the values of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is decreased (the magnet is moved further away).

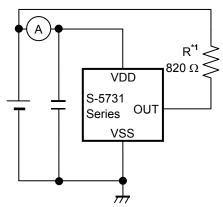
Even when the magnetic flux density falls below  $B_{RPN}$  or  $B_{RPS}$ ,  $V_{OUT}$  retains the status.

# **\*3.** $B_{HYSN}$ , $B_{HYSS}$ : Hysteresis widths

 $B_{HYSN}$  and  $B_{HYSS}$  are the difference between  $B_{OPN}$  and  $B_{RPN}$ , and  $B_{OPS}$  and  $B_{RPS}$ , respectively.

**Remark** The unit of magnetic density mT can be converted by using the formula 1 mT = 10 Gauss.

# **■** Test Circuits



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 5 Test Circuit 1

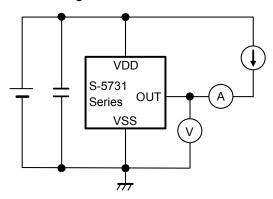


Figure 6 Test Circuit 2

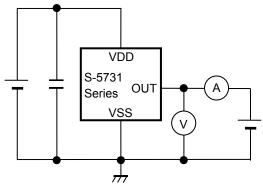
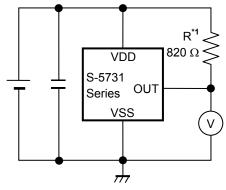
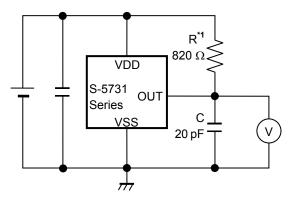


Figure 7 Test Circuit 3



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

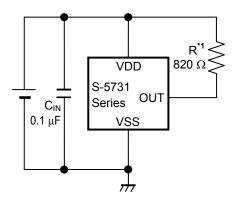
Figure 8 Test Circuit 4



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 9 Test Circuit 5

# **■** Standard Circuit



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 10

Caution The above connection diagram and constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

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# ■ Operation

# 1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface.

Figure 11 shows the direction in which magnetic flux is being applied.

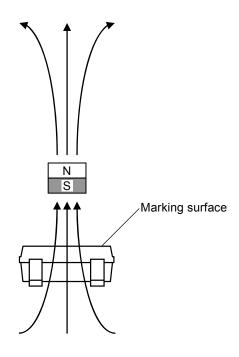


Figure 11

## 2. Position of Hall sensor

Figure 12 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

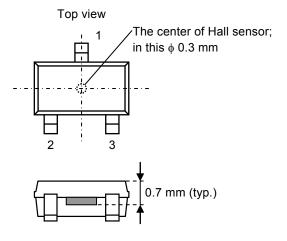


Figure 12

## 3. Basic operation

This IC changes the output voltage  $(V_{OUT})$  according to the level of the magnetic flux density (N pole or S pole) applied by a magnet.

The following explains the operation when the output logic is active "L".

#### 3. 1 Product with S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point ( $B_{OPS}$ ) after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the S pole of a magnet is moved further away from the marking surface of this IC and the magnetic flux density is lower than the release point ( $B_{RPS}$ ),  $V_{OUT}$  changes from "L" to "H".

Figure 13 shows the relationship between the magnetic flux density and V<sub>OUT</sub>.

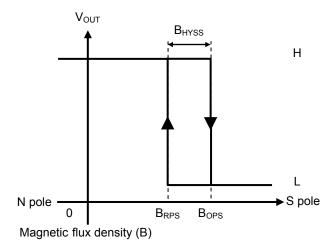


Figure 13

#### 3. 2 Product with N pole detection

When the magnetic flux density of the N pole perpendicular to the marking surface exceeds the operation point  $(B_{OPN})$  after the N pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the N pole of a magnet is moved further away from the marking surface of this IC and the magnetic flux density of the N pole is lower than the release point  $(B_{RPN})$ ,  $V_{OUT}$  changes from "L" to "H".

Figure 14 shows the relationship between the magnetic flux density and V<sub>OUT</sub>.

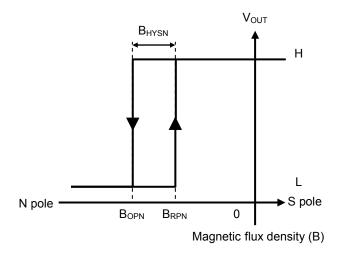


Figure 14

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# 4. Timing chart

**Figure 15** shows the operation timing at power-on.

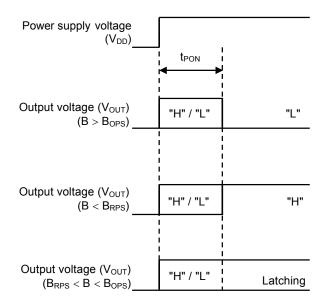
The initial output voltage at rising of power supply voltage (V<sub>DD</sub>) is either "H" or "L".

In case of B >  $B_{OPS}$  (operation point) or B <  $B_{RPS}$  (release point) at the time when the start up time ( $t_{PON}$ ) is passed after rising of  $V_{DD}$ , this IC outputs  $V_{OUT}$  according to the applied magnetic flux density.

In case of  $B_{\text{RPS}} < B < B_{\text{OPS}}$  at the time when  $t_{\text{PON}}$  is passed after rising of  $V_{\text{DD}}$ , this IC maintains the initial output voltage.

#### Product with S pole detection and active "L"

#### Product with S pole detection and active "H"



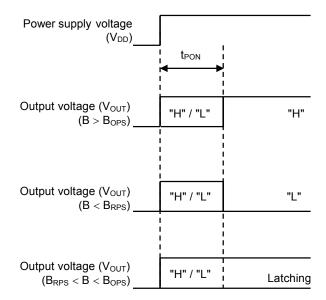


Figure 15

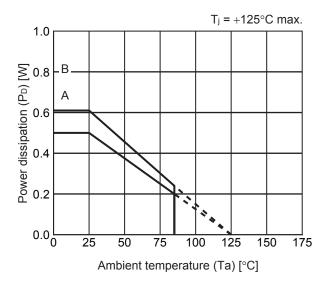
# HIGH-WITHSTAND VOLTAGE HIGH-SPEED UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC S-5731 Series Rev.1.1\_01

#### ■ Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feedthrough current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the
  environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC
  by reading it multiple times.
- Note that the output voltage may rarely change if the magnetic flux density between the operation point and the release point is applied to this IC continuously for a long time.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the power dissipation.
- Large stress on this IC may affect on the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

# **■** Power Dissipation

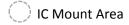
# SOT-23-3

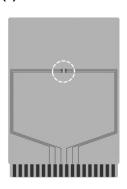


Board	Power Dissipation (P <sub>D</sub> )
A	0.50 W
В	0.61 W
С	_
D	_
Е	_

# **SOT-23-3/3S/5/6** Test Board

# (1) Board A





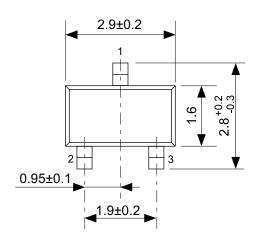
Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		2
	1	Land pattern and wiring for testing: t0.070
Coppor foil lover [mm]	2	-
Copper foil layer [mm]	3	-
	4	74.2 x 74.2 x t0.070
Thermal via		-

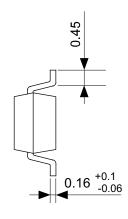
# (2) Board B

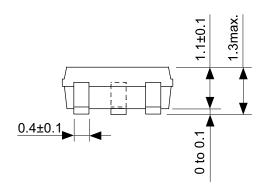


Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		4
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
Copper foil layer [min]	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		-

No. SOT23x-A-Board-SD-2.0

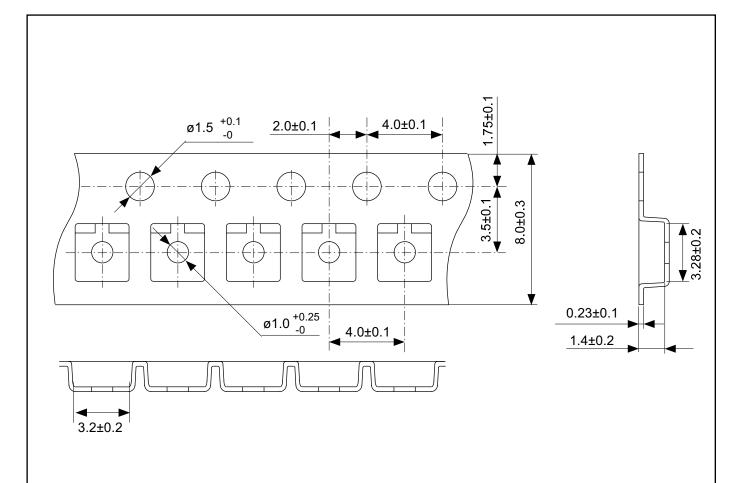


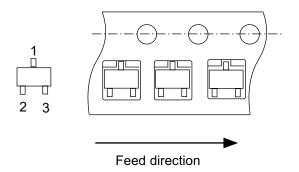




No. MP003-C-P-SD-1.1

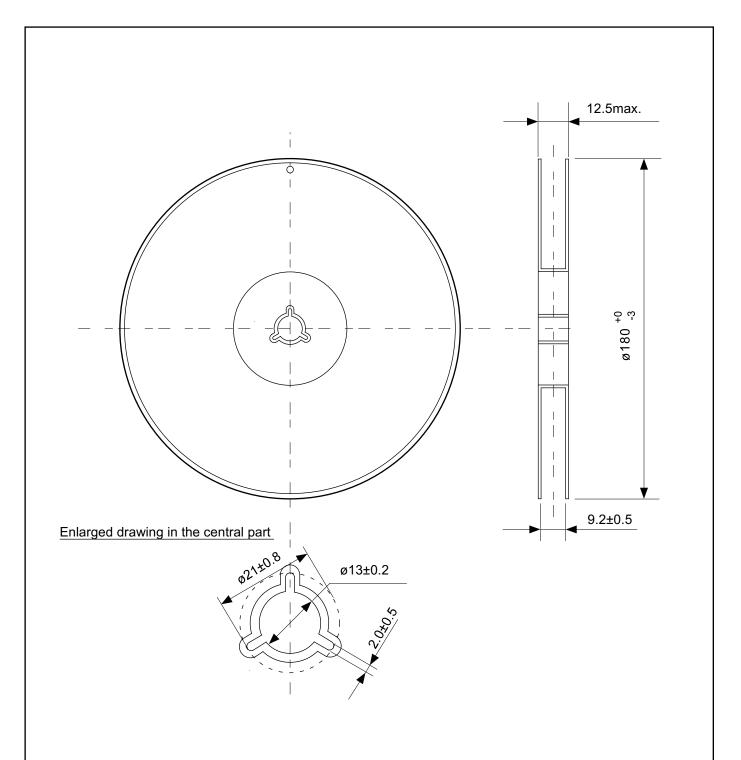
TITLE	SOT233-C-PKG Dimensions				
No.	MP003-C-P-SD-1.1				
ANGLE	<b>\$</b>				
UNIT	mm				
	ABLIC Inc.				
ADLIC IIIC.					





# No. MP003-C-C-SD-2.0

SOT233-C-Carrier Tape				
MP003-C-C-SD-2.0				
mm				
ABLIC Inc.				



# No. MP003-Z-R-SD-1.0

TITLE	SOT233-C-Reel		
No.	MP003-Z-R-SD-1.0		
ANGLE		QTY.	3,000
UNIT	mm		
ABLIC Inc.			

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